

### Study of Multimuon Events at CDF

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#### Outline

- Introduction
- History: *b* production and decay puzzles from the 1990s
- Recent results
  - Inclusive B cross sections
  - $b\overline{b}$  cross section
- New study of multimuon events



#### **Fermilab Tevatron**





### **CDF Detector**

- · Central tracking
- Silicon vertex detector
- Good lepton identification
- Particle ID (TOF and dE/dx)
- High rate trigger/DAQ system



- Differences in microvertex detectors discussed later.

#### **CDF** silicon detector installation



### Puzzles from the 1990's

# Three results related to *b* production and decay from Tevatron run I (1992-1996).

- 1.  $\sigma(pp \rightarrow b\overline{b}X)$  larger than expected from NLO QCD
- 2. Time-integrated mixing measured at Tevatron larger than LEP average

$$\overline{\chi} = \frac{\Gamma(B^0 \to \overline{B}^0 \to I^+ X)}{\Gamma(B \to I^\pm X)} = \frac{"same sign"}{"total"}, B^0 = B^0_d \text{ or } B^0_s$$

3. low mass dilepton spectrum inconsistent with expectations from heavy flavor.



#### I. B Cross Sections



- Two types of cross section measurements:
  - "Inclusive" = "single B"
    - Only require one reconstructed B
    - · Experimentally: high yield, can use clean, exclusive states,
      - e.g.  $B^+ \rightarrow J/\psi K^+$  or  $B^0 \rightarrow \mu D^0 X$
    - Theoretically: significant uncertainty from higher order contributions, fragmentation, structure functions
  - "Correlated bb" = "two B"
    - Both B's must be central with sufficient p<sub>T</sub>
    - Experimentally: BR\*efficiency for exclusive states too low, must use more inclusive techniques (vertex tagging, inclusive lepton tagging)
    - · Theoretically: smaller uncertainty because Born term dominates



### Inclusive $\sigma_b$

 Tevatron Run I (1992-1996):
 Inclusive cross sections systematically higher than NLO theory





#### Correlated $\sigma_{bb}$

#### • Measurement techniques

- Vertex tagging
- Lepton tagging

# "per jet" lepton rate also showed high relative rate



#### **Run I** σ<sub>bb</sub> measurements.

- Plot shows  $R_{2b} = \sigma_{bb}$  (measured)/ $\sigma_{bb}$  (NLO)
  - Vertex tag analyses consistent with R<sub>2b</sub>=1
  - Analyses using muons have  $R_{2b}$ >1.





#### **II. Time Integrated Mixing**

$$\overline{\chi} = \frac{\Gamma(B^0 \to \overline{B}^0 \to I^+ X)}{\Gamma(B \to I^\pm X)} = \frac{"same sign"}{"total"}, B^0 = B^0_d \text{ or } B^0_s$$

- Since  $B_d$  and  $B_s$  both oscillate:  $\overline{\chi} = f_s \chi_s + f_d \chi_d$ 
  - $f_d$  and  $f_s$  are fraction of *b* quarks that fragment into  $B_d$  and  $B_s$
  - $\chi_d$  and  $\chi_s$  are time integrated mixing parameters.

$$\chi_d = \frac{x_d^2}{2(1+x_d^2)}, \qquad \chi_s = \frac{x_s^2}{2(1+x_s^2)}$$

- Since  $x_d$  and  $x_s$  well measured, measure of  $\chi$  constrains production fractions.
- Expect same production fractions at Tevatron and LEP, since  $q^2 >> m_{u,d,s}^2$
- CDF Run I result (0.152±0.013) [PRD 69, 012002 (2004)] larger than LEP average (0.126 ±0.004)
  - · Different production fractions at high energy?



#### III. Low mass dileptons

- · Identify sample enriched in *B* decays.
- Look at "low mass" dileptons



- Should be well-modeled by simulation
- See poor agreement for  $m_{\mu\mu}$ <2 GeV

#### PRD 72, 072002 (2005)





### Puzzles from the 1990's

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$$\overline{\chi} = \frac{\Gamma(B^0 \to \overline{B}^0 \to l^+ X)}{\Gamma(B \to l^\pm X)} = \frac{"same sign"}{"total"}, B^0 = B^0_d \text{ or } B^0_s$$

3. low mass dilepton spectrum inconsistent with expectations from heavy flavor.

None of these are "showstoppers", but it is interesting to ask whether they are experimental or theoretical effects.





#### **CDF detector**





#### **CDF microvertex detector**

#### • silicon layer radii

- L00 1.6cm (on beampipe)
- L0 2.5cm
- L1 4.1cm
- ...

#### Impact parameter resolution:

- 230 μm (COT without Si)
- 30  $\mu$ m (COT with ≥3 Si hits)





#### **Dimuon Triggered Sample**





#### Impact parameter and decay length

- Impact parameter (d<sub>0</sub>) is the distance of closest approach of a track to the primary (*pp*) collision vertex
  - We will be looking at  $d_0(\mu)$  quite a bit
  - Impact parameter is a property of each track, do not need to reconstruct a secondary vertex.
- Decay length (L or  $L_{xy}$ ) is the flight distance between primay  $p\overline{p}$  collision vertex and secondary vertex.





### Step 1, re-measure $\sigma(p\bar{p} \rightarrow b\bar{b}X)$

#### Known sources of real dimuons

- $b \rightarrow \mu (c\tau = 470 \ \mu m)$
- $c \rightarrow \mu (c\tau = 210 \ \mu m)$
- Prompt (Y, Drell-Yan).

#### Known sources of fake muons

- Hadrons punching through calorimeter
- Hadrons that decay-in-flight
  - ·  $K \rightarrow \mu, \pi \rightarrow \mu$
- Fakes can be from prompt or heavy flavor sources.

#### Procedure

- Develop d<sub>0</sub> templates for
  - Heavy flavor (from MC)
  - Prompt sources (from data)
- Fit (in 2D) the  $d_0(\mu_1)$  versus  $d_0(\mu_2)$  distribution to extract contributions.
- Require our highest tracking precision to separate out prompt and charm backgrounds.
  - $\cdot$  Both  $\mu$  have hits on two innermost Si layers (L00 and L0)
- Correct for fake muon contribution to extract  $\sigma(pp \rightarrow bbX)$



- 1d projection of 2d templates
- Full fit includes all dimuon combinations
  - *bb*, *bc*, *cc*, *b*+prompt, *c*+prompt, prompt+prompt

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### Step 1, re-measure $\sigma(p\bar{p}\rightarrow b\bar{b}X)$



- Sample
  - 742 pb<sup>-1</sup>
  - Well modeled by templates
  - High purity: ~40% bb
- · Result
  - Measurement accuracy 10%
  - Good agreement with theory

#### PRD 77, 072004 (2008)



# Next, investigate "other" dimuons

- observe many more events rejected by the tight selection than expected.
  - Recall: tight selection requires muons have hits on two innermost silicon layers.
  - Implications

•

- more background than expected in total sample
- background removed by tight selection
- Much of this background was not removed because it appears at large impact parameter.
- Sample definitions
  - QCD = sum of contributions measured in bb cross section analysis (prompt, c and b)
  - Ghost = the excess after accounting for tight selection efficiency

Ghost = all events - (QCD/efficiency)



- QCD sources (includes heavy flavor) have  $d_0(\mu) < 0.5$  cm
- Ghost" events have much larger impact parameter!



#### **Tight Selection**

- · Charm contribution minimal for d>0.12cm
- Fit d<sub>0</sub> distribution for muons with 0.12<d<sub>0</sub><0.4cm Measure  $c\tau$ =469.7 ± 1.3 µm (stat. error only) PDG average b lifetime:  $c\tau$ =470.1 ± 2.7 µm



- Conclude:
  - Sample selected with tight cuts not appreciably affected by additional background.
  - *b* contribution almost fully exhausted for d<sub>0</sub>>0.5cm



Type	No SVX	Tight SVX	Loose SVX
All	743006	143743	590970
All OS		98218	392020
All SS		45525	198950
QCD	$589111 \pm 4829$	143743	$518417\pm7264$
QCD $OS$		98218	$354228\pm4963$
QCD $SS$		45525	$164188\pm2301$
Ghost	$153895\pm4829$	0	$72553\pm7264$
Ghost $OS$		0	$37792\pm4963$
Ghost SS		0	$34762\pm2301$



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QCD	$589111\pm4829$		143743	$518417 \pm 7264$
QCD $OS$	Assume same as "ALL tight"	$\prec$	98218	$354228 \pm 4963$
QCD $SS$			45525	$164188\pm2301$
Ghost	$153895\pm4829$	$\int$	0	$72553\pm7264$
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All SS		45525	198950
QCD	$589111\pm4829$		$518417 \pm 7264$
QCD OS			► 354228 ± 4963
QCD $SS$	Extrapolate from tight SVX yields using measured tight/loose efficiency	45525	$164188\pm2301$
Ghost	$153895\pm4829$	0	$72553\pm7264$
Ghost ${\cal OS}$		0	$37792 \pm 4963$
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QCD $OS$		98218	$354228 \pm 4963$
QCD $SS$		45525	$-164188\pm2301$
Ghost	$\textcircled{153895 \pm 4829}$	0	$72553 \pm 7264$
Ghost $OS$		0	$37792 \pm 4963$
Ghost $SS$	All – QCD = ghost	0	$34762 \pm 2301$

- $\cdot$  221564±11615 bb events with no SVX [194976 ± 10458 with loose requirements]
- Ghost contribution to entire sample (154k) comparable to bb contribution (222k)!



#### What about $\overline{\chi}$ ?

- Traditionally CDF measurements use loose SVX requirements (3 out of 8 silicon layers)
  - muons could originate as far as10.6 cm from the beam line
- CDF Run I analyses selected muons originating from distances as large as 5.7 cm from the beam line





#### What about $\overline{\chi}$ ?

Туре	No SVX	Tight SVX	Loose SVX
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- Run I measurements used selection closer to "loose SVX"
- Recall  $\chi$  = (same sign)/total
- Ghost sample ~50/50 in OS/SS  $\Rightarrow$  high value for  $\overline{\chi}$



### Where are we so far?

- Have a identified a source of background that was not previously considered.
- It is plausible that this background explains:
  - Run I  $\sigma(p\overline{p} \rightarrow bbX)$  larger than expected from NLO QCD
    - $\cdot\,$  Run II measurement with tight cuts agrees with prediction
  - Time-integrated mixing ( $\overline{\chi}$ ) measured at Tevatron larger than LEP average.
    - $\cdot\,$  Ghost contribution definitely affecting SS/OS ratio.
- · This does not (yet) explain
  - low mass dilepton spectrum inconsistent with expectations from heavy flavor.
- And we have not yet explained the source of this background.



### **Sources of Ghost Events**

What could give rise to real or fake muons at large d<sub>0</sub> which preferentially miss inner silicon layers?

- Mismeasured tracks
- In-flight decays of kaons and pions –  $K^{\pm} \rightarrow \mu \nu_{\mu}$  and  $\pi^{\pm} \rightarrow \mu \nu_{\mu}$
- Long lived particles (K<sub>s</sub>, hyperons)
- Secondary interactions in detector material
  - e.g. hadron interacts in silicon produces secondaries with large d<sub>0</sub>





#### **Mismeasurement?**





#### In-flight decays

• Use a heavy flavor simulation (HERWIG) to measure the probability that *K* and  $\pi$  decays produce trigger muons that pass all analysis cuts



 $\Delta$  is a  $\chi^2$ /NDOF based on the difference between the hadron at generator level and the reconstructed track in the  $\eta$ ,  $\phi$ ,  $p_T$  space



#### In-flight decays

- Probability per track that a hadron yields a trigger muon:
  0.07% pion and 0.34% kaon
- Normalize this rate from Herwig MC to measured  $b\overline{b}$  cross section
- prediction: 57000 ghost events from DIF
  - Recall: total ghost sample is: 154000 ±4800
- · Large uncertainty on the prediction coming from
  - total cross section, *bb* cross section, particle fractions ( $\pi/K$  ratio), momentum spectra, acceptance...
- In terms of total yield, in-flight decays could easily account for entire ghost sample.



1-Dec-0

#### In-flight decays









#### **Secondary interactions**

• Combine initial muons with tracks with  $p_T > 1$  GeV/c in a 40° cone





### **Sources of ghost events**

- Our prediction accounts for approximately 50% of observed number of ghost events (70000 out 150000 events)
  - uncertainty on the in-flight decay rate is large
  - cannot rule out a contribution from quasi-elastic secondary nuclear interactions
- At this point it appears that ghost events can be fully accounted for by a combination of in-flight and long-lived decays.



#### **Search for Additional Muons**

#### • Interesting for several reasons:

- Ghost events may be related to the excess of low mass dileptons
- Events due to secondary interactions or fake muons are not expected to contain many additional muons
- If ghosts events were normal QCD events with mismeasured initial muons, the rate of additional muons should be similar to that of QCD
- Search for additional muons with  $p_T > 2$  GeV/c and  $|\eta| < 1.1$  around each initial muon require invariant mass smaller than 5 GeV/c<sup>2</sup>
- Expectation:
  - the main source of real additional muons are sequential decays of *b* quarks
  - a sizable contribution of muons mimicked by hadrons.
- Analysis strategy:
  - perform loose muon selection to get maximal acceptance
  - take higher fake muon rate, correct for it by precisely assessing fakes.



#### **Muon Fake Rate**

- Measure the probability per track that a pion or kaon will "punch through" the calorimeter and fake a muon.
- Technique:
  - Reconstruct  $D^{*+} \rightarrow D^0 \pi^+$  decays with a  $D^0 \rightarrow K^- \pi^+$
  - D\* tag uniquely identifies  $\pi$  and K
  - Reconstruction by tracking only, then ask at what rate were the hadrons found as muons?





#### Verifying the fake rate

 Compare data to heavy flavor simulation which includes fake prediction.





- 6935±154 in the data and 6998±293 predicted
- We understand the heavy flavor simulation and the fake muon background



#### Low mass dileptons

- Compare data to heavy flavor simulation which includes fake prediction.
- · Total sample:





- $J/\psi$  yield correctly modeled
  - See a clear excess at low mass.
    - Tight SVX sample didn't show this
    - Excess coming from ghost sample

Same as the low mass dilepton puzzle from Run I.



#### **Multiplicities**

- QCD sample well understood
- Ghost sample less well understood, but appears to be mostly QCD-like, with muons from in-flight and long-lived decays.

#### Compare ghost to QCD:

- 1. After correcting for fakes, the rate of additional muons in Ghost sample 4x larger than QCD
  - If mostly DIF, expect additional muon contribution to be suppressed, not enhanced.
- Number of charged tracks (p<sub>T</sub>>2GeV) in Ghost sample 2x larger than QCD



#### **Additional muons**

- · Additional muons very close to trigger muon
- Virtually all  $\mu$  have cos $\theta$ >0.8 with respect to nearest trigger  $\mu$
- Evaluate additional muons within a cone of  $\cos\theta > 0.8$  around initial muon





#### additional muon multiplicity

- Plot is muons in a single cone in Ghost sample.
   after fake correction counting additional muons (not trigger muon) in a single cone.
- $\cdot$  Relative to trigger  $\mu$ 
  - OS μ: +1
  - SS μ: +10
- Example:
  - Trigger  $\mu^+$ , find 2  $\mu^+$  and 1 $\mu^-$  in cone: plot in bin 21



#### On average, a multiplicity increase of one unit corresponds to a population decrease of 7



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### **Cone correlations**



SMU Seminar

**Ghost events** 

27790±761 cones with  $\geq$  2  $\mu$ **(a)** 

4133±263 cones with  $\geq$  3  $\mu$ 

3016 with  $\geq$  2  $\mu$  in both cones (b)

Ratio (b)/(a) = 0.11 is quite large. Events triggered by a central jet, the fraction of events containing another central jet is 10-15%





#### **Impact parameter**

- Look at impact parameter of additional muons
  - Additional muons not biased by trigger





#### Where are we now?

- After correcting for fakes, the rate of additional muons in Ghost sample 4x larger than QCD sample
   If mostly DIF, expect additional muon contribution to be suppressed, not enhanced.
- 2. Some events have very large muon multiplicities (3 or 4 muons in a cone)
- 3. Number of charged tracks ( $p_T$ >2GeV) in Ghost sample 2x larger than QCD sample
- 4. Impact parameter of additional muons extends well beyond that of QCD sample



### **Back to the Puzzles**

# Three results related to *b* production and decay from Tevatron run I (1992-1996).

- 1.  $\sigma(pp \rightarrow bb\overline{X})$  larger than expected from NLO QCD
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$$\overline{\chi} = \frac{\Gamma(B^0 \to \overline{B}^0 \to I^+ X)}{\Gamma(B \to I^\pm X)} = \frac{"same sign"}{"total"}, B^0 = B^0_d \text{ or } B^0_s$$

3. low mass dilepton spectrum inconsistent with expectations from heavy flavor.

#### These puzzles all appear to be plausibly explained by the new background we have identified...but what is the background?



#### **On the Ghost Sample**

- The QCD sample is well explained by our understanding of the detector, reconstruction and the physics.
- We have identified a large background sample that was unexpected.
  - Its size is comparable to  $b\overline{b}$  production.
- · Much of the background can be explained by in-flight decays along with  ${\rm K}_{\rm S}$  and hyperons
- Another piece of this background is puzzling, it seems inconsistent with any of our expectations.
  - This component of the background shows high muon and charged track multipliticy



#### **Comment on fake rates**

- Our "per track" fake probability assumes that fake muons are uncorrelated.
- Probably not completely true
  - high energy jet  $\Rightarrow$  large leakage  $\Rightarrow$  lots of activity in muon chambers  $\Rightarrow$  lots of fake muons
- We don't posses any calibration sample that allows us to directly probe this effect.
- Requiring tighter muon selection and higher purity muons do not affect the salient features of the ghost sample.
- If the high multiplicity events are caused by correlated fakes, why don't we see it in the QCD sample?
- Calling all high multiplicity events as "fake" only removes 1/3 of the excess over QCD.



#### QCD vs. Ghost

- If the high multiplicity events are caused by correlated fakes, why don't we see it in the QCD sample?
- Correlated fake muons not seen to be a problem in other analyses, e.g. soft lepton tagging for top decays.



- Total charged momentum spectrum,  $\Sigma p_T$ , is similar between Ghost and QCD samples.
  - Ghost sample slightly harder in  $\Sigma p_T$



#### **Summary**

- Through the study of multimuon events, we believe we have found a plausible explanation for a number of puzzles which have been around for a decade.
- We have identified a sample of events which appear to have some very unique properties.
- We currently cannot explain these events, and we have not ruled out known processes.